Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/812,947	YOSHIDA, SEIKOH
Examiner	Art Unit
Monica Lewis	2822

SEARCHED				
Class	Subclass	Date	Examiner	
257	192,213	8/29/2007	ML	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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Interferen	ce Search	8/29/2007	ML

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	DAT		EXMR
East Search	8/28/2	2007	ML
EIC Search	8/28/2	2007	ML